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ICG 1077

U.S. UTILITY Patent Application

PATENT NUMBER and
ISSUE DATE

APPL NUM 10033364	FILING DATE 12 26 2001	CLASS 324	SUBCLASS	GAU 2558	EXAMINER / / / / /
**APPLICANTS: Di Gregorio Giuseppe Gambina Maria Luisa Russo Biagio					
**CONTINUING DATA VERIFIED: THIS APPLN CLAIMS BENEFIT OF 60 259 346 12 29 2000					
** FOREIGN APPLICATIONS VERIFIED:					
PG-PUB <input type="checkbox"/> DO NOT PUBLISH <input type="checkbox"/>		RESCIND <input type="checkbox"/>		ATTORNEY DOCKET NO 956063 678	
TITLE : Test board de-embedding method to improve RF measurements accuracy on an automatic testing equipment for IC wafers					

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
		Total Claims	Print Claim for O.G
ISSUE FEE		DRAWING	
Amount Due	Date Paid	Sheets Drwg.	Figs. Drwg. Print Fig.
<input type="checkbox"/> TERMINAL DISCLAIMER		Application Examiner	
		PREPARED FOR ISSUE	
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